

# An Active Time-Constant Variation Tuning Technique for Continuous-Time Delta-Sigma Modulators

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06. – 07. March 2023

## Problem Statement

Continuous-time (CT) loop filter coefficients relate on Time Constants (TC).

$$TC \sim (R * C)$$

$$\text{or } TC \sim (C/g_m)$$

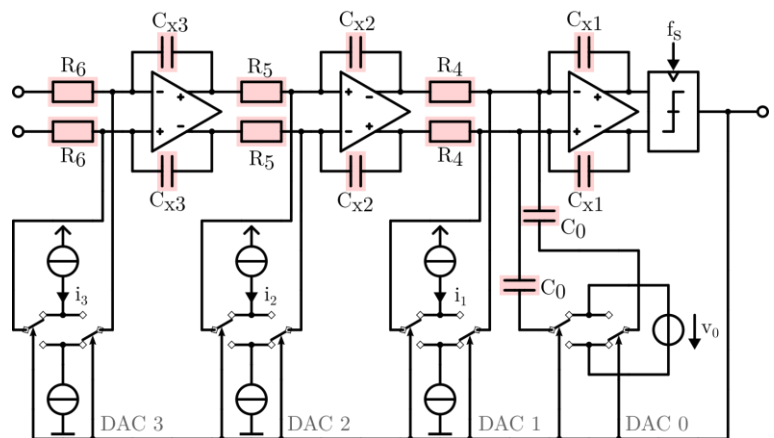
In CMOS technologies:  $\Delta TC \cong \pm 30\%$

$$TC + \Delta TC = TC \cdot (1 + \delta_{RC})$$

TC variation in CT  $\Delta\Sigma$  Modulators:

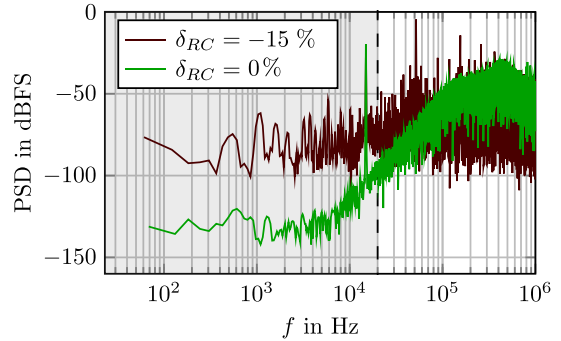
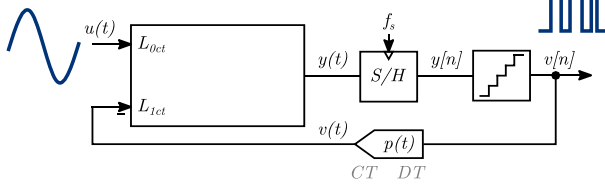
- Transfer characteristics
  - Signal Transfer Function (STF)
  - Noise Transfer Function (NTF)
- Performance
  - In-Band Noise (IBN)
  - Signal-to-Noise Ratio (SNR)
- Stability
  - Maximum Stable Amplitude (MSA)

Example: 3<sup>rd</sup> order 1-bit low-pass CT  $\Delta\Sigma$  modulator in CIFB structure with current-steering feedback DACs and ELD compensation



# Problem Statement

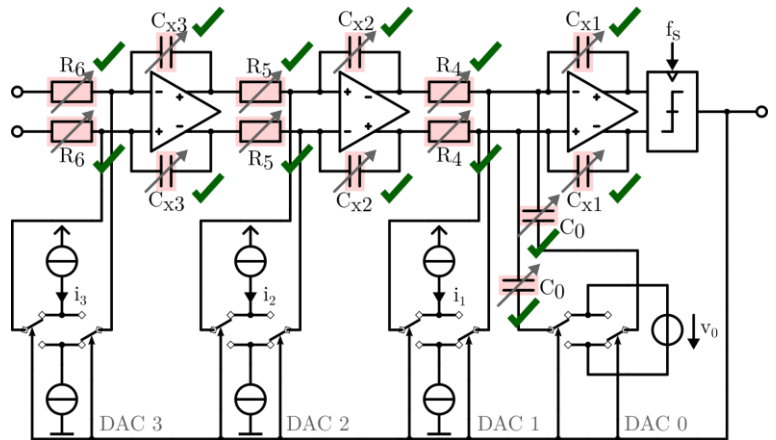
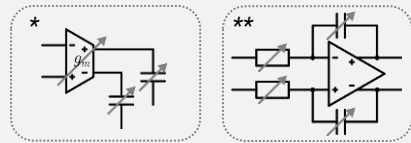
## Worst Case: Instability due to Time-Constant Variation



# State of the Art

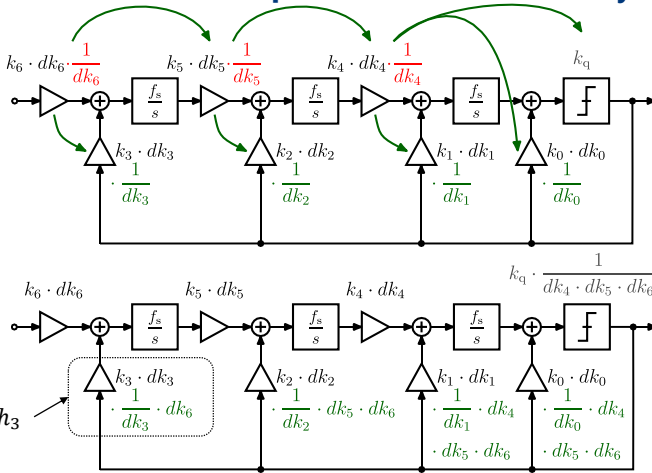
### Design Options for CT ΔΣ Modulators:

- No tuning + design margin [Gerfers, IEEE Journal of SSC, 2003]
- $g_m$ -C integrators \*
  - $g_m$ -tuning
  - C-tuning [Xia, IEEE ISCAS, 2002]
- Active R-C-integrators \*\*
  - R-tuning
  - C-tuning [Billa, IEEE JSSC, 2020]



# Proposed Tuning Technique

## TC Variation Compensation Factors on System Level



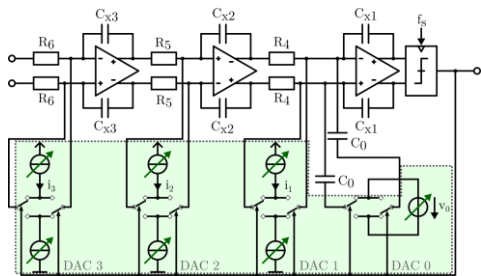
$h_i$  : Effective modulator coefficients  
 $k_i$  : Nominal modulator coefficients  
 $dk_i$  : Individual influence of TC variation  
 $\{...\}$  : Compensation factors to be implemented

$h_6 = k_6 \cdot dk_6$
$h_5 = k_5 \cdot dk_5$
$h_4 = k_4 \cdot dk_4$
$h_3 = k_3 \cdot dk_3 \cdot \left\{ \frac{1}{dk_3} \cdot dk_6 \right\}$
$h_2 = k_2 \cdot dk_2 \cdot \left\{ \frac{1}{dk_2} \cdot dk_5 \cdot dk_6 \right\}$
$h_1 = k_1 \cdot dk_1 \cdot \left\{ \frac{1}{dk_1} \cdot dk_4 \cdot dk_5 \cdot dk_6 \right\}$
$h_0 = k_0 \cdot dk_0 \cdot \left\{ \frac{1}{dk_0} \cdot dk_4 \cdot dk_5 \cdot dk_6 \right\}$
$h_q = k_q \cdot \frac{1}{dk_4 \cdot dk_5 \cdot dk_6}$

Ref.: [T. Wolfer and E. Hennig, IEEE APCCAS, 2021]  
 [T. Wolfer and E. Hennig, IEEE SMACD, 2022]

# Proposed Tuning Technique

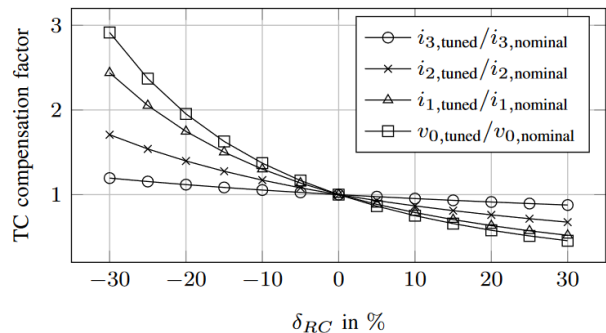
## Reference Tuning Scheme on Circuit Level



DAC 3:	$i_3 = i_{3,nominal} \cdot \left\{ \frac{1}{dk_3} \cdot dk_6 \right\}$
DAC 2:	$i_2 = i_{2,nominal} \cdot \left\{ \frac{1}{dk_3} \cdot dk_5 \cdot dk_6 \right\}$
DAC 1:	$i_1 = i_{1,nominal} \cdot \left\{ \frac{1}{dk_1} \cdot dk_4 \cdot dk_5 \cdot dk_6 \right\}$
DAC 0:	$v_0 = v_{0,nominal} \cdot \left\{ \frac{1}{dk_0} \cdot dk_4 \cdot dk_5 \cdot dk_6 \right\}$

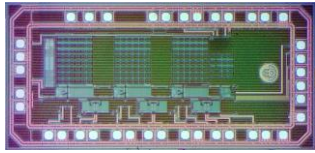
Relative Time-Constant (TC) Variation:

$$\delta_{RC} = \frac{1}{(1 + \Delta R) \cdot (1 + \Delta C)}$$

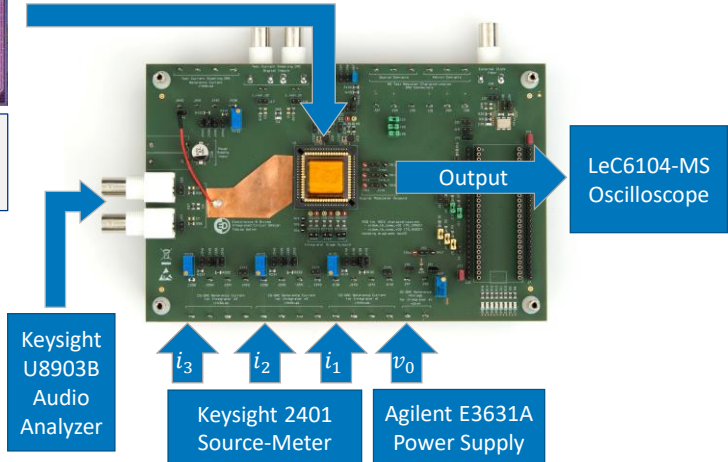


Example:  $dk_3 = \frac{1}{(1 + \Delta R_6) \cdot (1 + \Delta C_{x3})}$

# Test Chip and Measurement Setup



Fabricated CT  $\Delta\Sigma$  modulators test-chip samples



# Measurement: Spectrum vs. TC Variation

## TC Errors Compensated for all Parameter Variations

